Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | VAN EYK ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,508,202	04-1996	Enomoto et al.	436/69
	В	US-5,840,508	11-1998	Switchenko et al.	435/7.32
	С	US-4,376,825	03-1983	Rubenstein et al.	435/188
	D	US-4,563,423	01-1986	Murray et al.	435/69.3
,	Е	US-6,322,976	11-2001	Aitman et al.	435/6
	F	US-4,654,419	03-1987	Vaughan et al.	530/326
	G	US-6,020,139	02-2000	Schwartz et al.	435/7.1
	Н	US-5,616,460	04-1997	Figard, Steve D.	435/5
	1	US-5,994,507	11-1999	Pilotti et al.	530/362
	J	US-4,376,825	03-1983	Rubenstein et al.	435/188
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.